TOSHIBA Bipolar Digital Integrated Circuit Silicon Monolithic

# TD62006PG,TD62006FG

## 6ch Darlington Sink Driver

The TD62006PG/TD62006FG Series are high-voltage, high-current darlington drivers comprised of six NPN darlington pairs.

All units feature integral clamp diodes for switching inductive loads and protective diodes against a negative input voltage.

The TD62006PG and TD62006FG are suitable for interfaces from minus and plus dual supply voltage system to plus single supply voltage system.

Applications include relay, hammer, lamp and display (LED)

Please observe the thermal condition for using. The suffix (G) appended to the part number represents a Lead (Pb)-Free product.

#### **Features**

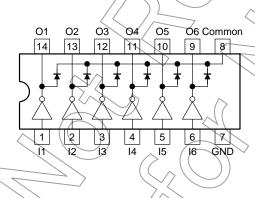
- Output current (single output): 150 mA (max)
- High sustaining voltage output: 22 V (min)
- Output clamp diodes
- Protective diodes against a negative input voltage
- Inputs base resistor:  $R_{IN} = 20 \text{ k}\Omega$
- Inputs compatible with 9 to 15 V PMOS, CMOS
- Package type-PG: DIP-14 pin
- Package type-FG: SOP-14 pin

# TD62006PG DIP14-P-300-2.54 7D62006FG SOP14-P-225-1.27

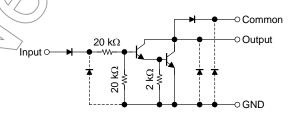
Weight/

DIP14-P-300-2.54: 1.11 g (typ.) SOP14-P-225-1.27: 0.16 g (typ.)

## Pin Connection (top view)



## Schematics (each driver)



Note: The input and output parasitic diodes cannot be used as clamp diodes.

2006-06-13

## Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit		
Output sustaining voltage	Э	V <sub>CE</sub> (SUS)	-0.5 to 22	V	
Output current	I <sub>OUT</sub>	150	mA/ch		
Input voltage	V <sub>IN</sub>	-37 to 22	V		
Clamp diode reverse volt	age	V <sub>R</sub>	22	V	
Clamp diode forward cur	rent	I <sub>F</sub>	150	mA	
Power dissipation	PG	PD	1.0	W	
	FG	רט	0.625 (Note)		
Operating temperature	PG	т	-30 to 75	°C	
	FG	T <sub>opr</sub>	-40 to 85		
Storage temperature		T <sub>stg</sub>	-50 to 150	°C	

Note: On glass epoxy PCB (50  $\times$  50  $\times$  1.6 mm Cu 30%)

## Recommended Operating Conditions (Ta = -40 to 85°C and Ta = -30 to 75°C for Type-PG)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit	
Output sustaining voltage		V <sub>CE</sub> (SUS)	-	>,6~	_	20	V	
Output current		IOUT (	DC 1 Circuit	) •	_	120	mA/ch	
			Tpw = 25 ms, Duty = 10%, 6 Circuits	0	_	100		
Input voltage		VIN		-35		20	V	
Clamp diode reverse voltage		V <sub>R</sub> (	- //			20	٧	
Clamp diode forward current		İF		_	_	120	mA	
Power dissipation	PG	$\left( \begin{array}{c} P_{D} \end{array} \right)$	<u>\</u>			0.44	W	
	FG	(1)	Ta = 85°C (Note)	_		0.325	VV	

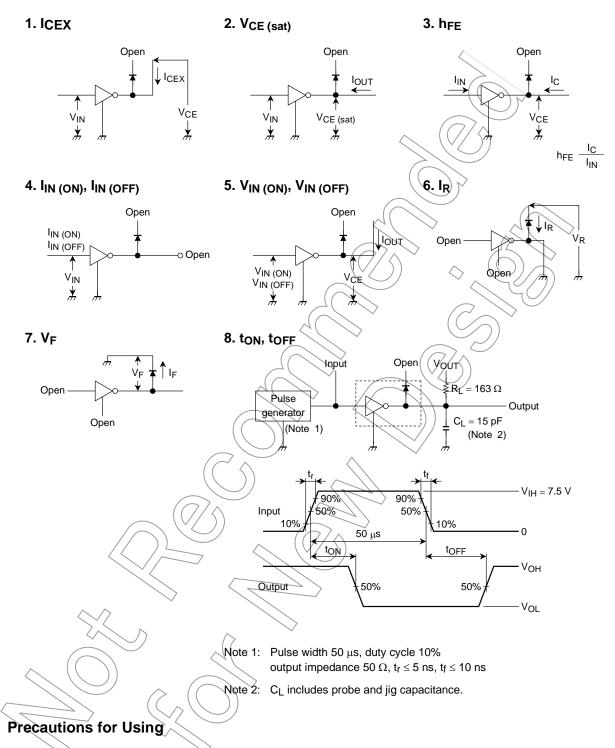
Note: On glass epoxy PCB ( $50 \times 50 \times 1.6$  mm Cu 30%)

## Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Тур.	Max	Unit
Output leakage current PG ICEX		1	V <sub>OUT</sub> = 20 V V <sub>IN</sub> = 1.0 V	Ta = 75°C	_	_	100	μА	
FG		~(7		VIN = 1.0 V	Ta = 85°C				
Collector-emitter saturation voltage		V <sub>CE</sub> (sat)	2	$V_{IN} = 7.5 \text{ V}, I_{OUT} = 120 \text{ mA}$		_	_	1.6	V
DC current transfer ratio		hFE	3	VCE = 2.0 V, I <sub>OUT</sub> = 120 mA		800	_	_	
Input current	High level	IIN (ON)	- 4	$V_{IN} = 7.5 V$				0.7	mA
	Low level	IN (OFF)		$V_{IN} = -35 \text{ V}$				-10	μΑ
Input voltage	High level	VIN (ON)	- 5	I <sub>OUT</sub> = 120 mA				7.5	V
	Low level	V <sub>IN (OFF)</sub>				1		_	
Clamp diode reverse current		$I_{R}$	6	V <sub>R</sub> = 20 V			_	30	μΑ
Clamp diode forward voltage		V <sub>F</sub>	7	I <sub>F</sub> = 120 mA		_	_	1.6	V
Turn-on delay		t <sub>ON</sub>	8	$V_{OUT}$ = 20 V, $R_L$ = 167 $\Omega$ $C_L$ = 15 pF			0.1		μS
Turn-off delay		tOFF	8				0.4		μS

2

### **Test Circuit**

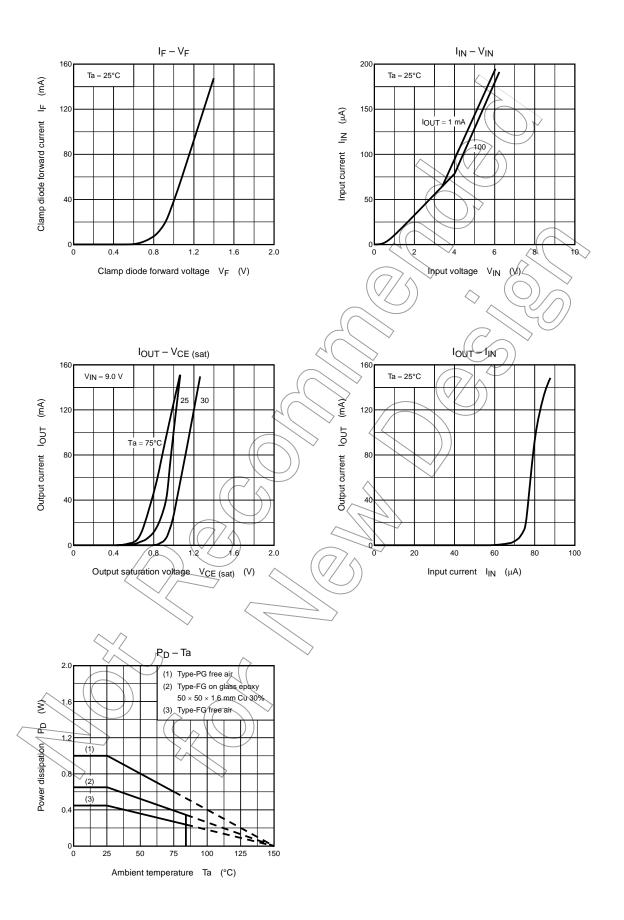


This IC does not include built-in protection circuits for excess current or overvoltage.

If this IC is subjected to excess current or overvoltage, it may be destroyed.

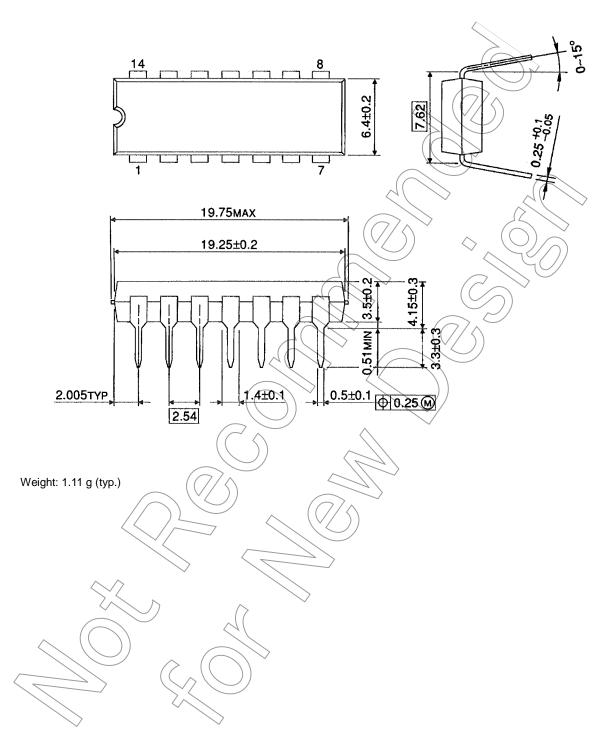
Hence, the utmost care must be taken when systems which incorporate this IC are designed.

Utmost care is necessary in the design of the output line, COMMON and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.



## **Package Dimensions**

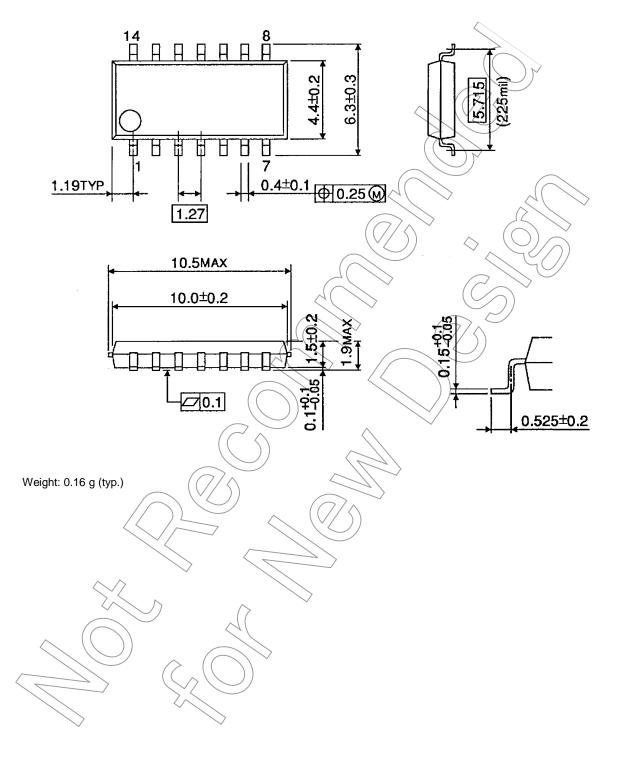




5 2006-06-13

## **Package Dimensions**

SOP14-P-225-1.27 Unit: mm



6 2006-06-13

#### **Notes on Contents**

#### 1. Equivalent Circuits

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

#### 2. Test Circuits

Components in the test circuits are used only to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

## IC Usage Considerations

## Notes on Handling of ICs

- (1) The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings.
  Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
- (2) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- (3) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition.

  Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
- (4) Do not insert devices in the wrong orientation or incorrectly.

  Make sure that the positive and negative terminals of power supplies are connected properly.

  Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.

  In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.
- (5) Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator.

  If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.

## Points to Remember on Handling of ICs

(1) Heat Radiation Design

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature (Tj) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into considerate the effect of IC heat radiation with peripheral components.

(2) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flow back to the motor's power supply due to the effect of back-EMF. If the current sink eapability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond absolute maximum ratings. To avoid this problem, take the effect of back-EMF into



8 2006-06-13

About solderability, following conditions were confirmed

- Solderability
  - (1) Use of Sn-37Pb solder Bath
    - solder bath temperature = 230°C
    - · dipping time = 5 seconds
    - · the number of times = once
    - · use of R-type flux
  - (2) Use of Sn-3.0Ag-0.5Cu solder Bath
    - · solder bath temperature = 245°C
    - · dipping time = 5 seconds
    - · the number of times = once
    - · use of R-type flux

#### **RESTRICTIONS ON PRODUCT USE**

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   In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as

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